

## **Product Change Notification / ASER-27LSSS520**

Date:

05-Apr-2021

#### **Product Category:**

Access Networks, Broadband Gateway

# **PCN Type:**

Manufacturing Change

# **Notification Subject:**

CCB 4514 Final Notice: Qualification of MTAI as an additional assembly site for selected MSCC products available in 48L VQFN (7x7x1mm) package.

#### **Affected CPNs:**

ASER-27LSSS520\_Affected\_CPN\_04052021.pdf ASER-27LSSS520\_Affected\_CPN\_04052021.csv

#### **Notification Text:**

**PCN Status:** Final notification.

**PCN Type:**Manufacturing Change

Microchip Parts Affected: Please open one of the attachments found in the Affected CPNs section.

NOTE: For your convenience Microchip includes identical files in two formats (.pdf and .csv).

**Description of Change:**Qualification of MTAI as an additional assembly site for selected MSCC products available in 48L VQFN (7x7x1mm) package.

#### **Pre and Post Change Summary:**

		Pre C		Post Change						
Assembly Site		ASE Group -Malaysia (ASEM)	Unisem Chengdu Co.,Ltd.	Microchip Technology Thailand	ASE Group -Malaysia (ASEM)	Unisem Chengdu Co.,Ltd.	Microchip Technology Thailand	Microchip Technology Thailand		

			(UNIC)	(MMT)		(UNIC)	(MMT)	(MTAI)
	Wire aterial	PdCu	CuPdAu	CuPdAu	PdCu	CuPdAu	CuPdAu	CuPdAu
Die Attach Material		CRM1076DS	8290	3280	CRM1076DS	8290	3280	3280
Cor	Mold npound aterial	CEL-9240HF10AK-G1	G770HP	G700LTD	CEL-9240HF10AK-G1	G770HP	G700LTD	G700LTD
	d Frame aterial	A194	A194	A194	A194	A194	A194	A194
Lea	d Frame	No	No	Yes	No	No	Yes	Yes
Le	ad-lock		Se	e Pre and Post (	Change Summary for compa	rison.	-	

Impacts to Data Sheet:None

Change Impact:None

Reason for Change:To improve manufacturability by qualifying MTAI as an additional assembly site.

**Change Implementation Status:**In Progress

**Estimated First Ship Date:** 

March 30, 2021 (date code: 2114)

NOTE: Please be advised that after the estimated first ship date customers may receive pre and post change parts.

#### **Time Table Summary:**

	February 2021			March 2021				April 2021					
Workweek	0 6	0 7	0	0 9	1 0	1	1 2	1	1	1 5	1 6	1 7	1 8
Initial PCN Issue Date		х											
Qual Report Availability											Х		
Final PCN Issue Date											Х		
Estimated Implementation Date									x				

Method to Identify Change:Traceability code

#### **Qualification Report:**

Please open the attachments included with this PCN labeled as PCN\_#\_Qual\_Report.

**Revision History:February 12, 2021:** Issued initial notification. **April 5, 2021:** Issued final notification. Attached the Qualification Report. Removed Pre and Post Change fields. Provided estimated first ship date to be on March 30, 2021.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content

of the applicable products.
Attachments:  PCN_ASER-27LSSS520_Pre and Post Change Summary.pdf PCN_ASER-27LSSS520_Qual Report.pdf
Please contact your local Microchip sales office with questions or concerns regarding this notification.  Terms and Conditions:
If you wish to <u>receive Microchip PCNs via email</u> please register for our PCN email service at our <u>PCN</u> home page select register then fill in the required fields. You will find instructions about registering for Microchips PCN email service in the <u>PCN FAQ</u> section.
If you wish to change your PCN profile, including opt out, please go to the PCN home page select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.

ASER-27LSSS520 - CCB 4514 Final Notice: Qualification of MTAI as an additional assembly site for selected MSCC products available in 48L VQFN (7x7x1mm) package.

## Affected Catalog Part Numbers(CPN)

LE9641PQC

LE9651PQC

LE9641PQCT

LE9651PQCT

LE89156PQC

LE89156PQCT

LE9642PQC

LE9642PQCT

LE9652PQC

ZL88107LDG1

LE9652MPQC

LE9652PQCT

ZL88107LDF1

LE9652MPQCT

LE79272PQC

LE79272PQCT

LE9530CPQC

LE9530DPQC

LE9530CPQCT

LE9530DPQCT

# CCB 4514 Pre and Post Change Summary PCN #: ASER-27LSSS520

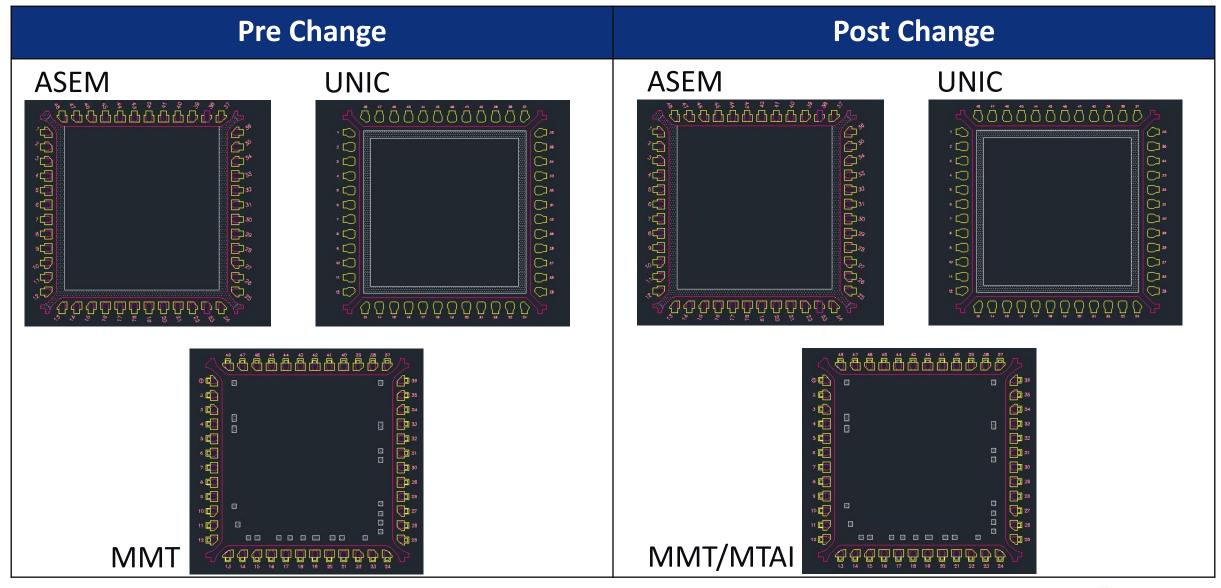


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Qualification of MTAI as an additional assembly site for selected MSCC products available in 48L VQFN (7x7x1mm) package.

# **Lead frame Comparison**







# QUALIFICATION REPORT SUMMARY RELIABILITY LABORATORY

PCN#: ASER-27LSSS520

Date: April 2, 2021

Qualification of MTAI as an additional assembly site for selected MSCC products available in 48L VQFN (7x7x1mm) package.

Purpose Qualification of MTAI as an additional assembly site for selected MSCC products

available in 48L VQFN (7x7x1mm) package.

**CCB No.** 4514

**CN** ES351324

 QUAL ID
 R2100011 Rev. C

 MP CODE
 3411H7M9CA01

Part No. LE9652PQC

Bonding No. BDM-002786 Rev. A

**Package** 

Type 48L VQFN
Package size 7x7x1.0 mm

**Lead Frame** 

Paddle size 232 x 232 mils

Material A194

**Surface** Ag selective Plated

Process Etched
Lead Lock Yes

**Part Number** 10104808

**Material** 

**Epoxy** 3280

Wire CuPdAu wire

Mold Compound G700LTD

Plating Composition Matte Tin

# **Manufacturing Information**

Assembly Lot No.	Wafer Lot No.	Date Code
MTAI213802513.000	GF07921225657.200	2051C75
MTAI213802989.000	GF07921225657.200	2051DQ0
MTAI213802998.000	GF07921225657.200	2051DW3

Result		X Pass	Fail					
	48L VQFN	(7x7x1.0 mm) a	assembled by	MTAI pa	ass reliability	test per Q	CI-39000.T	his

48L VQFN (7x7x1.0 mm) assembled by MTAI pass reliability test per QCI-39000. This package was qualified the Moisture/Reflow Sensitivity Classification Level 3 at 260°C reflow temperature per IPC/JEDEC J-STD-020E standard.

PACKAGE QUALIFICATION REPORT									
Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS	Result	Remarks			
Precondition Prior Perform Reliability Tests	Electrical Test: +25°C System: CHROMA3650	JESD22- A113	693(0)	693		Good Devices			
At MSL Level 3)	Bake 150°C, 24 hrs System: CHINEE	JIP/ IPC/JEDEC J-STD-020E		693					
	30°C/60%RH Moisture Soak 192 hrs. System: TABAI ESPEC Model PR-3SPH			693					
	3x Convection-Reflow 265°C max			693					
	System: Vitronics Soltec MR1243								
	Electrical Test: +25°C System: CHROMA3650			0/693	Pass				

Test Number	Test Condition	Standard/	Qty.	Def/SS.	Result	Remarks
(Reference)		Method	(Acc.)			
	Stress Condition: -65°C to +150°C, 500 Cycles System: TABAI ESPEC TSA-70H	JESD22- A104		231		Parts had been pre-conditioned at 260°C
	Electrical Test: +25°C System: CHROMA3650		231(0)	0/231	Pass	77 units / lot
Temp Cycle	Stress Condition: -65°C to +150°C, 1000 Cycles System: TABAI ESPEC TSA-70H			231		
	Electrical Test: +25°C System: CHROMA3650		231(0)	0/231	Pass	
	Bond Strength: Wire Pull (> 2.5 grams) Bond Shear (>15.00 grams)		15 (0) 15 (0)	0/15 0/15	Pass Pass	
	Stress Condition: +130°C/85%RH, 96 hrs. System: HAST 6000X	JESD22- A118		231		Parts had been pre-conditioned at 260°C
	Electrical Test: +25°C System: CHROMA3650		231(0)	0/231	Pass	77 units / lot
UNBIASED- HAST	Stress Condition: +130°C/85%RH, 192 hrs. System: HAST 6000X			231		
	Electrical Test: +25°C System: CHROMA3650		231(0)	0/231	Pass	

PACKAGE QUALIFICATION REPORT							
Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks	
High Temperature Storage Life	Stress Condition: Bake 175°C, 504 hrs System: SHEL LAB	JESD22- A103		45		45 units	
	Electrical Test: +25°C System: CHROMA3650		45(0)	0/45	Pass		
Solderability	Steam Aging: Temp 93°C,8Hrs System: SAS-3000	J-STD-002	22 (0)	22			
Temp 215°C	Solder Dipping: Solder Temp.215°C Solder material: SnPb Sn63, Pb37 System: ERSA RA 2200D Visual Inspection: External Visual Inspection			22 0/22	Pass		
Solderability	Steam Aging: Temp 93°C,8Hrs System: SAS-3000	J-STD-002	22 (0)	22			
Temp 245°C	Solder Dipping:Solder Temp.245°C			22			
	Solder material:Pb Free Sn 95.5Ag3.9 Cu0.6 System: ERSA RA 2200D Visual Inspection: External Visual Inspection			0/22	Pass		
Bond Strength	Wire Pull (> 2.5 grams)	Mil.Std. 883-2011	30 (0) Wires	0/30	Pass		
Data Assembly	Bond Shear (>15.00 grams)	CDF-AEC- Q100-001	30 (0) bonds	0/30	Pass		